

Chipsmall Limited consists of a professional team with an average of over 10 year of expertise in the distribution of electronic components. Based in Hongkong, we have already established firm and mutual-benefit business relationships with customers from, Europe, America and south Asia, supplying obsolete and hard-to-find components to meet their specific needs.

With the principle of "Quality Parts, Customers Priority, Honest Operation, and Considerate Service", our business mainly focus on the distribution of electronic components. Line cards we deal with include Microchip, ALPS, ROHM, Xilinx, Pulse, ON, Everlight and Freescale. Main products comprise IC, Modules, Potentiometer, IC Socket, Relay, Connector. Our parts cover such applications as commercial, industrial, and automotives areas.

We are looking forward to setting up business relationship with you and hope to provide you with the best service and solution. Let us make a better world for our industry!



Contact us

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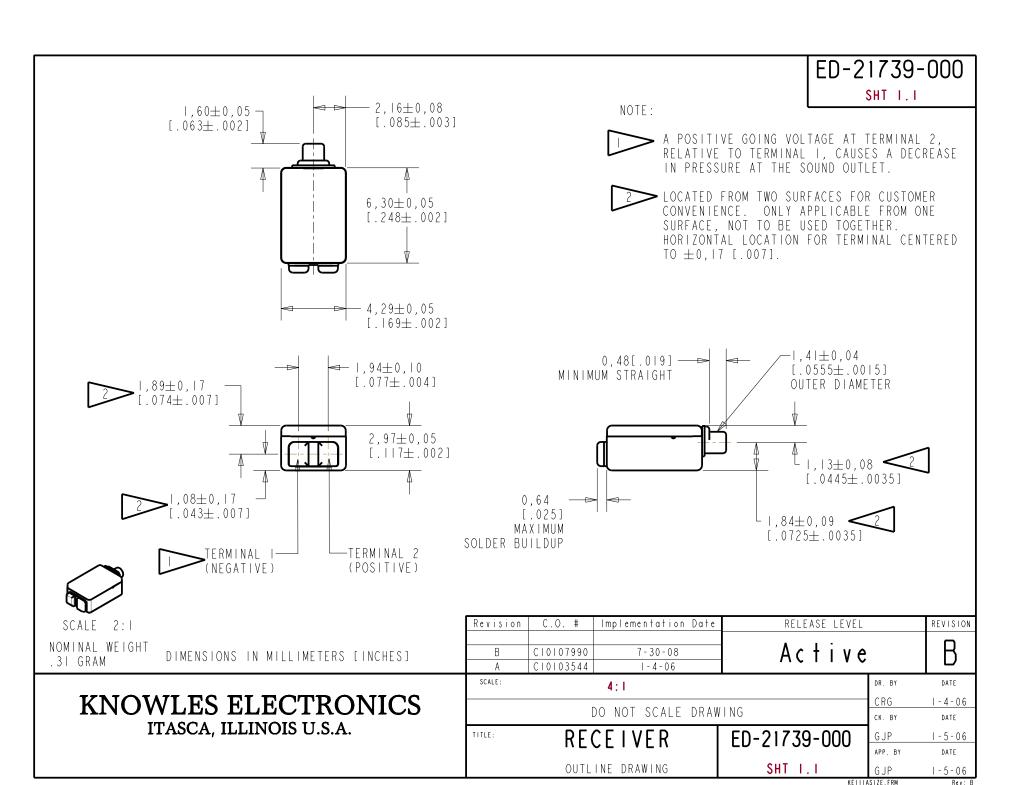
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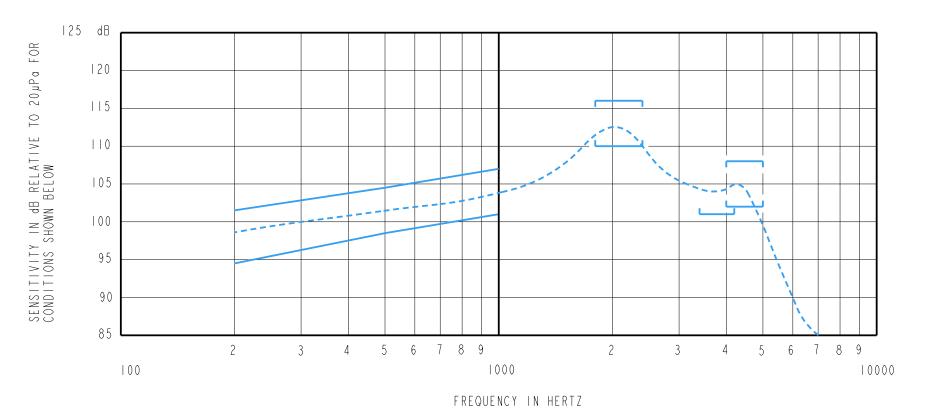








TYPE II DAMPING



NOTES:

I. MEASUREMENTS MADE USING 10mm (.394") X 1mm (.039") ID TUBE CONNECTED TO A SIMULATED ANSI \$3.7-1973 TYPE HA-3 COUPLER. (IEC 126).

2.	SENSITIVITY	
FREQUENCY	MIN.	MAX.
200	94.5	101.5
500	98.5	104.5
1000	101.0	107.0
1800-2400	110.0	116.0
3400-4200	101.0	
4000-5000	102.0	108.0

- 3. RESPONSE, IMPEDANCE, AND DISTORTION MEASUREMENTS MADE USING THE ELECTRICAL TEST CONDITIONS SHOWN BELOW.
- 4. ELECTRICAL SOURCE IMPEDANCE MUST BE GREATER THAN 20 TIMES IKHZ IMPEDANCE FOR TEST CONDITIONS SHOWN BELOW.
- 5. INDIVIDUAL SPECIFICATIONS.

PORT LOCATION		DANCE ±15%	DCR @20°C	DISTORTION		ELECTRICAL TEST CONDITIONS		
	I K H z	500Hz	OHMS ±10%	MAX. %	FREQ Hz	AC mA RMS	DC mA	
120	2	1500	825	376	5	800	0.50	0.70

Revision	C.O. #	Implementation Date	RELEASE LEVEL		REVISION
B A	C10107990 C10103544	7 - 30 - 08 I - 4 - 06	Active		В
WHEN TEST LIMITS ARE USED TO ESTABLISH INCOMING INSPECTION ACCEPTANCE/REJECTION CRITERIA, CORRELATION OF TEST EQUIPMENT WITH KNOWLES IS ALSO REQUIRED FOR FILMINATION OF FOULPMENT AND TEST METHOD VARIATION				DR. BY	DATE 1 - 4 - 0 6
				CK. BY	DATE
TITLE:	RF	CFIVFR	ED-21739-000	GJP	I - 5 - 0 6
		02.72		APP. BY	DATE

PERFORMANCE SPECIFICATION SHT 2.1

KNOWLES ELECTRONICS
ITASCA, ILLINOIS U.S.A.